

# Six-Pack SPT<sup>+</sup> IGBT

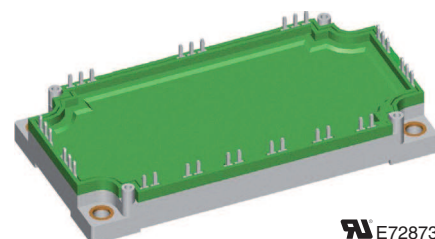
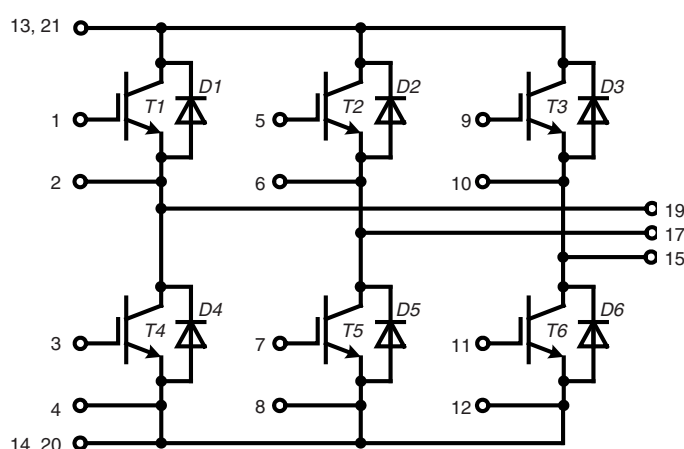
$$V_{CES} = 1200 \text{ V}$$

$$I_{C25} = 183 \text{ A}$$

$$V_{CE(sat)} = 1.8 \text{ V}$$

**Part name** (Marking on product)

MIEB101W1200EH



 E72873

## Features:

- SPT<sup>+</sup> IGBT technology
- low saturation voltage
- low switching losses
- square RBSOA, no latch up
- high short circuit capability
- positive temperature coefficient for easy paralleling
- MOS input, voltage controlled
- SONIC<sup>™</sup> free wheeling diode
  - fast and soft reverse recovery
  - low operation forward voltage
- solderable pins for PCB mounting
- package with copper base plate

## Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

## Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting

**Output Inverter T1 - T6**

|                |                                                           |                                                                                                                                             |                                                                 | Ratings    |            |               |   |
|----------------|-----------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------|------------|------------|---------------|---|
| Symbol         | Definitions                                               | Conditions                                                                                                                                  | min.                                                            | typ.       | max.       | Unit          |   |
| $V_{CES}$      | collector emitter voltage                                 | $T_{VJ} = 25^{\circ}\text{C}$                                                                                                               |                                                                 |            | 1200       | V             |   |
| $V_{GES}$      | max. DC gate voltage                                      | continuous                                                                                                                                  |                                                                 |            | $\pm 20$   | V             |   |
| $V_{GEM}$      | max. transient collector gate voltage                     | transient                                                                                                                                   |                                                                 |            | $\pm 30$   | V             |   |
| $I_{C25}$      | collector current                                         | $T_C = 25^{\circ}\text{C}$                                                                                                                  |                                                                 |            | 183        | A             |   |
| $I_{C80}$      |                                                           | $T_C = 80^{\circ}\text{C}$                                                                                                                  |                                                                 |            | 128        | A             |   |
| $P_{tot}$      | total power dissipation                                   | $T_C = 25^{\circ}\text{C}$                                                                                                                  |                                                                 |            | 630        | W             |   |
| $V_{CE(sat)}$  | collector emitter saturation voltage<br>(on chip level) ① | $I_C = 100\text{ A}; V_{GE} = 15\text{ V}$                                                                                                  | $T_{VJ} = 25^{\circ}\text{C}$<br>$T_{VJ} = 125^{\circ}\text{C}$ | 1.8<br>2.0 | 2.2<br>2.4 | V<br>V        |   |
| $V_{GE(th)}$   | gate emitter threshold voltage                            | $I_C = 4\text{ mA}; V_{GE} = V_{CE}$                                                                                                        | $T_{VJ} = 25^{\circ}\text{C}$                                   | 5          | 6          | 7             | V |
| $I_{CES}$      | collector emitter leakage current                         | $V_{CE} = V_{CES}; V_{GE} = 0\text{ V}$                                                                                                     | $T_{VJ} = 25^{\circ}\text{C}$<br>$T_{VJ} = 125^{\circ}\text{C}$ |            | 0.3<br>3   | mA<br>mA      |   |
| $I_{GES}$      | gate emitter leakage current                              | $V_{GE} = \pm 20\text{ V}$                                                                                                                  |                                                                 |            | 200        | nA            |   |
| $C_{ies}$      | input capacitance                                         | $V_{CE} = 25\text{ V}; V_{GE} = 0\text{ V}; f = 1\text{ MHz}$                                                                               |                                                                 | 7430       |            | pF            |   |
| $Q_{G(on)}$    | total gate charge                                         | $V_{CE} = 600\text{ V}; V_{GE} = 15\text{ V}; I_C = 100\text{ A}$                                                                           |                                                                 | 750        |            | nC            |   |
| $t_{d(on)}$    | turn-on delay time                                        | inductive load<br>$V_{CE} = 600\text{ V}; I_C = 100\text{ A}$<br>$V_{GE} = \pm 15\text{ V}; R_G = 10\text{ }\Omega$<br>$L_S = 70\text{ nH}$ | $T_{VJ} = 125^{\circ}\text{C}$                                  | 120        |            | ns            |   |
| $t_r$          | current rise time                                         |                                                                                                                                             |                                                                 | 55         |            | ns            |   |
| $t_{d(off)}$   | turn-off delay time                                       |                                                                                                                                             |                                                                 | 460        |            | ns            |   |
| $t_f$          | current fall time                                         |                                                                                                                                             |                                                                 | 240        |            | ns            |   |
| $E_{on}$       | turn-on energy per pulse                                  |                                                                                                                                             |                                                                 | 9.5        |            | mJ            |   |
| $E_{off}$      | turn-off energy per pulse                                 |                                                                                                                                             |                                                                 | 9.7        |            | mJ            |   |
| $E_{rec(off)}$ | reverse recovery losses at turn-off                       |                                                                                                                                             |                                                                 | 4.2        |            | mJ            |   |
| <b>RBSOA</b>   | reverse bias safe operating area                          | $V_{GE} = \pm 15\text{ V}; R_G = 10\text{ }\Omega;$                                                                                         | $T_{VJ} = 125^{\circ}\text{C}$<br>$V_{CEK} = 1200\text{ V}$     |            | 200        | A             |   |
| <b>SCSOA</b>   | short circuit safe operating area                         |                                                                                                                                             |                                                                 |            |            |               |   |
| $t_{sc}$       | short circuit duration<br>short circuit current           | $V_{CE} = 900\text{ V}; V_{GE} = \pm 10\text{ V};$<br>$R_G = 3.9\text{ }\Omega;$ non-repetitive                                             | $T_{VJ} = 125^{\circ}\text{C}$                                  |            | 10         | $\mu\text{s}$ |   |
| $R_{thJC}$     | thermal resistance junction to case                       | (per IGBT)                                                                                                                                  |                                                                 |            | 0.2        | K/W           |   |

**Output Inverter D1 - D6**

|            |                                      |                                                                                                                                             |                                                                 | Ratings      |              |               |
|------------|--------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------|--------------|--------------|---------------|
| Symbol     | Definitions                          | Conditions                                                                                                                                  | min.                                                            | typ.         | max.         | Unit          |
| $V_{RRM}$  | max. repetitive reverse voltage      | $T_{VJ} = 25^{\circ}\text{C}$                                                                                                               |                                                                 |              | 1200         | V             |
| $I_{F25}$  | forward current                      | $T_C = 25^{\circ}\text{C}$                                                                                                                  |                                                                 |              | 135          | A             |
| $I_{F80}$  |                                      | $T_C = 80^{\circ}\text{C}$                                                                                                                  |                                                                 |              | 90           | A             |
| $V_F$      | forward voltage<br>(on chip level) ① | $I_F = 100\text{ A}; V_{GE} = 0\text{ V}$                                                                                                   | $T_{VJ} = 25^{\circ}\text{C}$<br>$T_{VJ} = 125^{\circ}\text{C}$ | 2.00<br>1.95 | 2.20<br>2.25 | V<br>V        |
| $I_{rr}$   | max. reverse recovery current        | inductive load<br>$V_{CE} = 600\text{ V}; I_C = 100\text{ A}$<br>$V_{GE} = \pm 15\text{ V}; R_G = 10\text{ }\Omega$<br>$L_S = 70\text{ nH}$ | $T_{VJ} = 125^{\circ}\text{C}$                                  | 120          |              | A             |
| $t_{rr}$   | reverse recovery time                |                                                                                                                                             |                                                                 | 330          |              | ns            |
| $Q_{rr}$   |                                      |                                                                                                                                             |                                                                 | 12.5         |              | $\mu\text{C}$ |
| $E_{rec}$  |                                      |                                                                                                                                             |                                                                 | 4.2          |              | mJ            |
| $R_{thJC}$ | thermal resistance junction to case  | (per diode)                                                                                                                                 |                                                                 |              | 0.4          | K/W           |

 $T_C = 25^{\circ}\text{C}$  unless otherwise stated

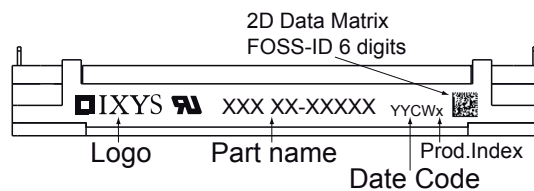
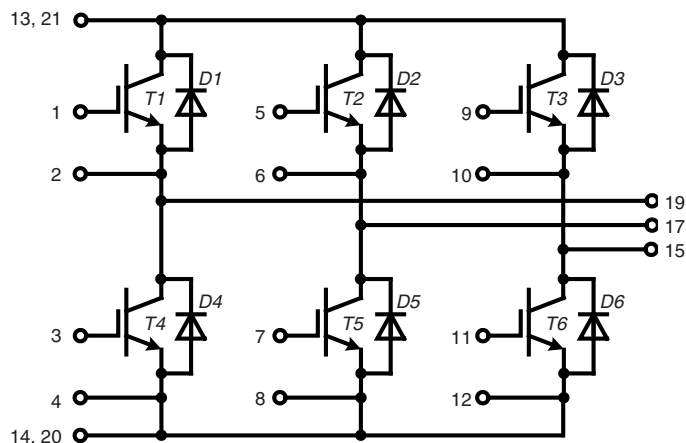
| Module                    |                                     |                                                                                            |      |         |              |          |
|---------------------------|-------------------------------------|--------------------------------------------------------------------------------------------|------|---------|--------------|----------|
| Symbol                    | Definitions                         | Conditions                                                                                 | min. | Ratings |              | Unit     |
|                           |                                     |                                                                                            |      | typ.    | max.         |          |
| $T_{VJ}$                  | operating temperature               |                                                                                            | -40  |         | 125          | °C       |
| $T_{VJM}$                 | max. virtual junction temperature   |                                                                                            |      |         | 150          | °C       |
| $T_{stg}$                 | storage temperature                 |                                                                                            | -40  |         | 125          | °C       |
| $V_{ISOL}$                | isolation voltage                   | $I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$<br>$t = 1 \text{ min}$<br>$t = 1 \text{ s}$ |      |         | 3000<br>3600 | V~<br>V~ |
| <b>CTI</b>                | comparative tracking index          |                                                                                            |      |         | 200          |          |
| $M_d$                     | mounting torque (M5)                |                                                                                            | 3    |         | 6            | Nm       |
| $R_{pin \text{ to chip}}$ | see ①                               |                                                                                            |      | 1.8     |              | mΩ       |
| $d_S$                     | creep distance on surface           |                                                                                            | 12.7 |         |              | mm       |
| $d_A$                     | strike distance through air         |                                                                                            | 9.6  |         |              | mm       |
| $R_{thCH}$                | thermal resistance case to heatsink | with heatsink compound                                                                     |      | 0.1     |              | K/W      |
| <b>Weight</b>             |                                     |                                                                                            |      | 300     |              | g        |

①  $V_{CE} = V_{CE(sat)} + 2 \times R_{pin \text{ to chip}} \cdot I_C$

$T_C = 25^\circ\text{C}$  unless otherwise stated

Curves are measured on modul level except Fig. 14 to Fig. 17

### Circuit Diagram

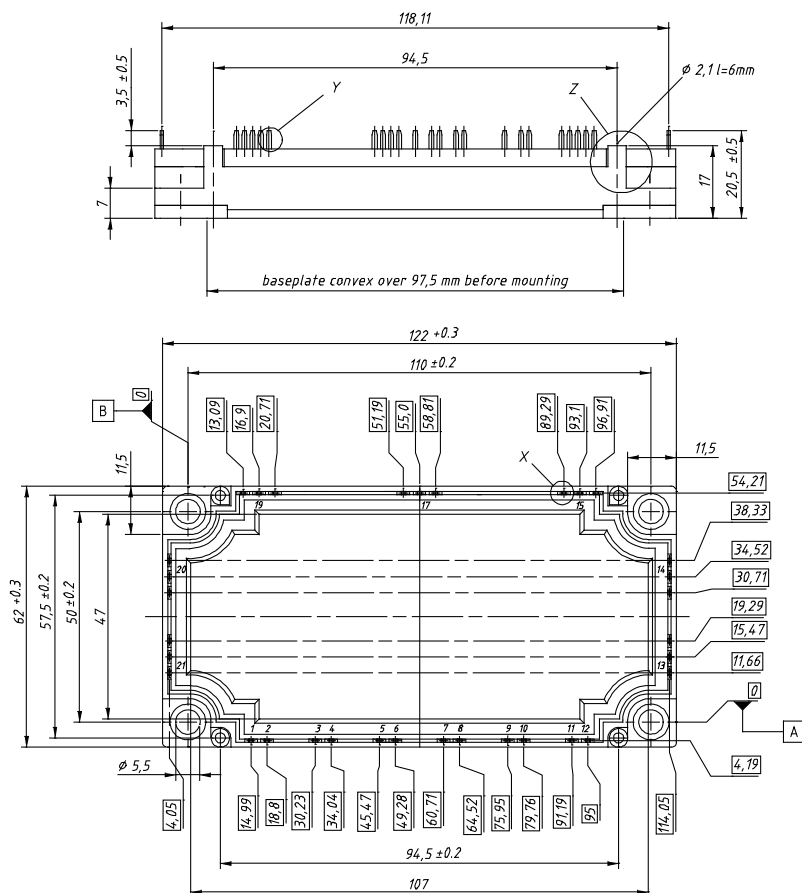


## Part number

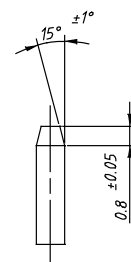
M = Module  
I = IGBT  
E = SPT  
B = 2nd Generation  
101 = Current Rating [A]  
W = Six-Pack  
1200 = Reverse Voltage [V]  
EH = E3-Pack

## Outline Drawing

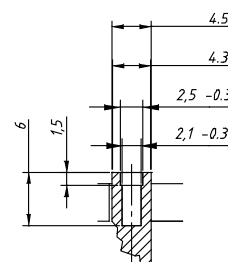
Dimensions in mm (1 mm = 0.0394")



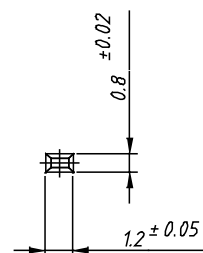
Detail Y



*Detail Z*



Detail X



## Product Marking

| Ordering | Part Name      | Marking on Product | Delivering Mode | Base Qty | Ordering Code |
|----------|----------------|--------------------|-----------------|----------|---------------|
| Standard | MIEB101W1200EH | MIEB101W1200EH     | Box             | 5        | 509522        |

## Transistor T1 - T6

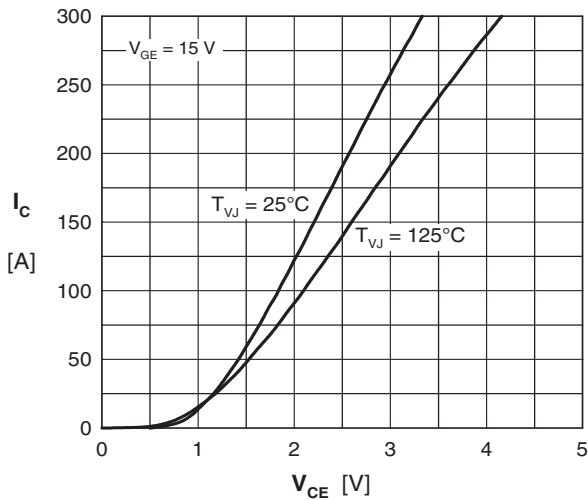


Fig. 1 Typ. output characteristics

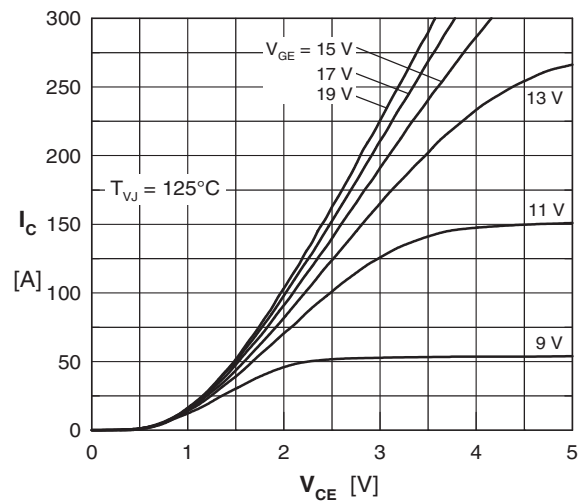


Fig. 2 Typ. output characteristics

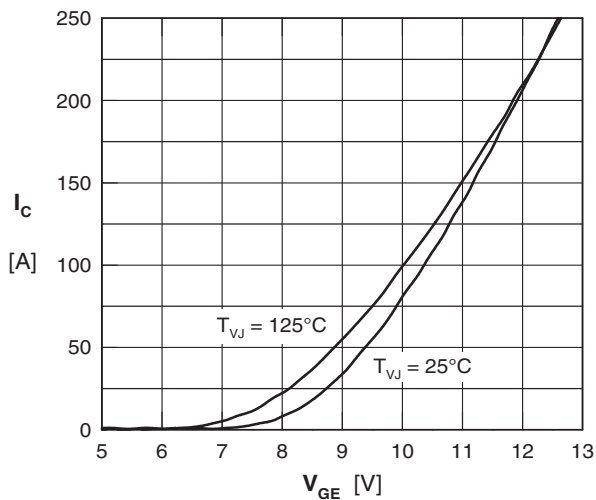


Fig. 3 Typ. transfer characteristics

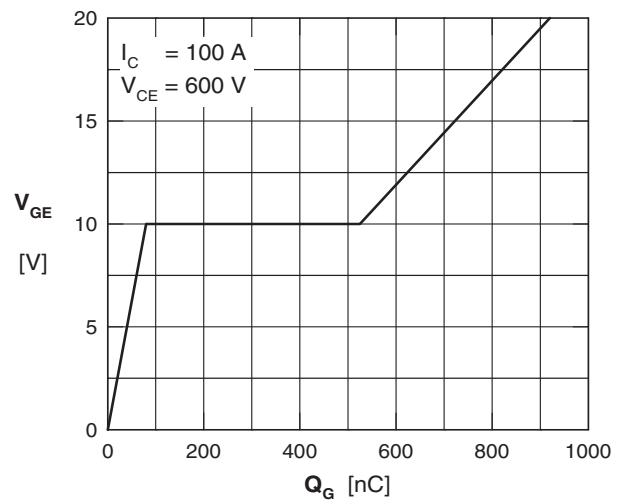


Fig. 4 Typ. turn-on gate charge

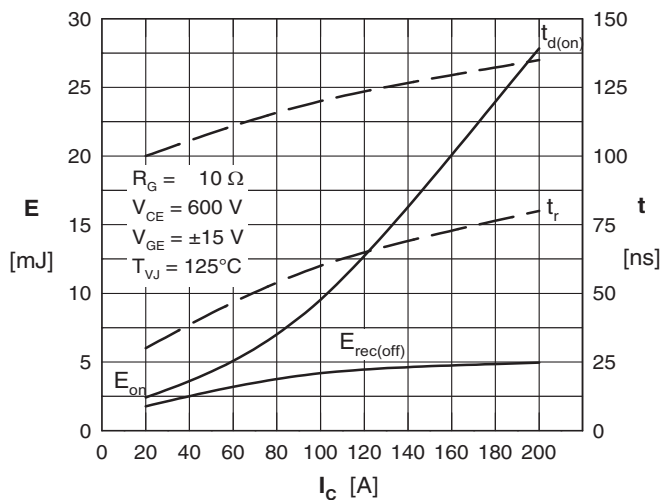


Fig. 5 Typ. turn-on energy & switching times versus collector current

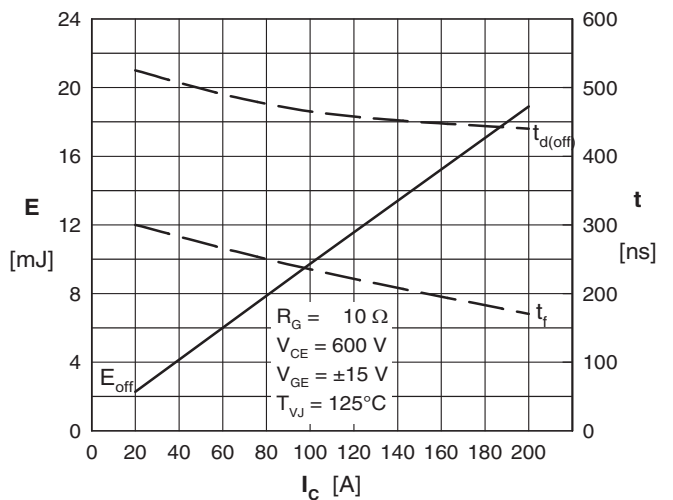


Fig. 6 Typ. turn-off energy & switching times versus collector current

## Transistor T1 - T6

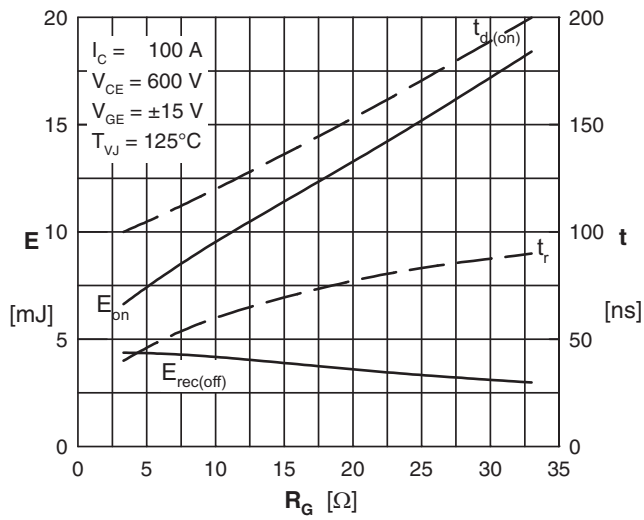


Fig. 7 Typ. turn-on energy and switching times versus gate resistor

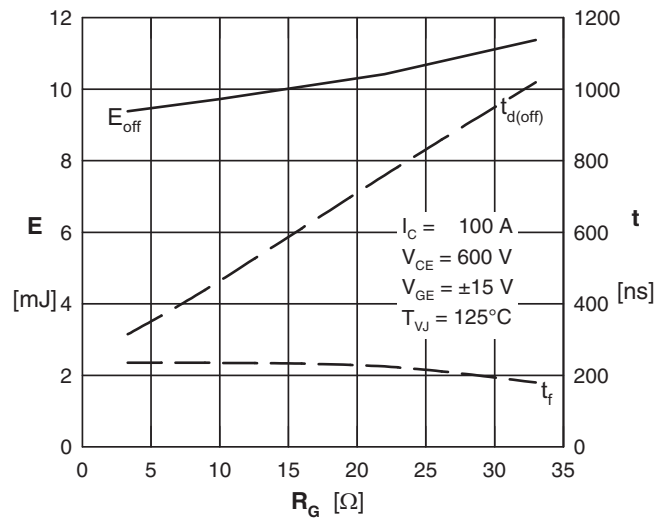


Fig. 8 Typ. turn-off energy and switching times versus gate resistor

## Diode D1 - D6

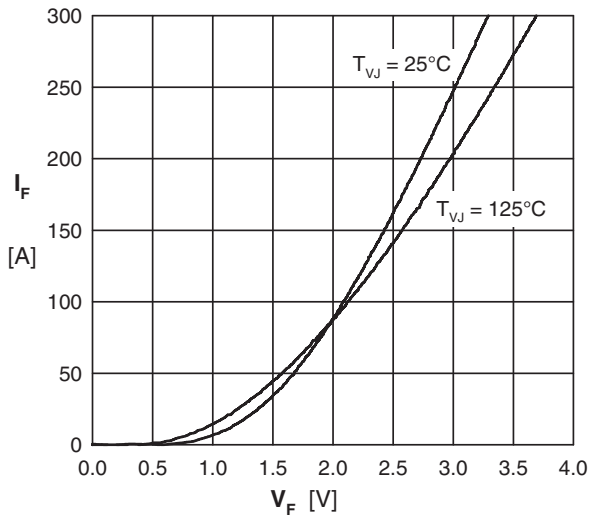


Fig. 9 Typ. forward characteristics

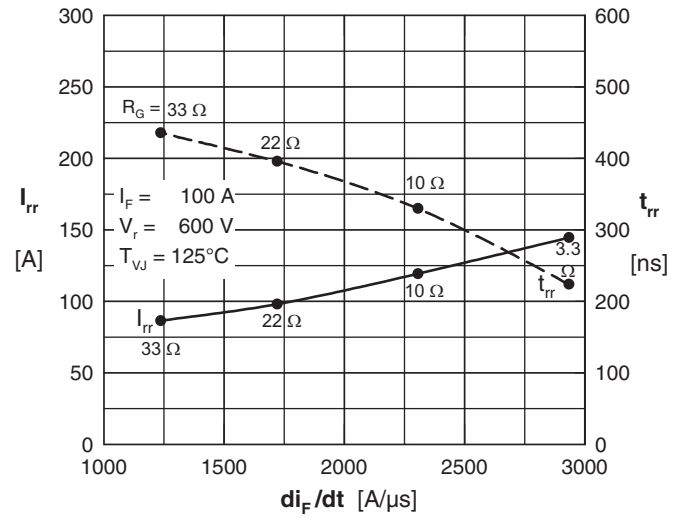


Fig. 10 Typ. reverse recovery characteristics

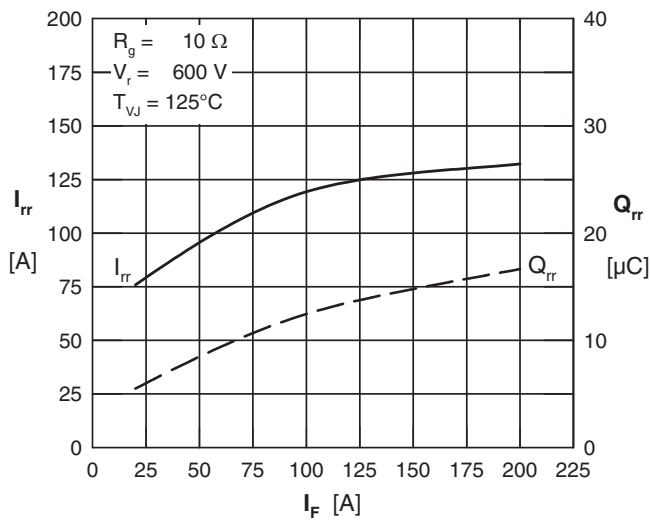


Fig. 11 Typ. reverse recovery characteristics

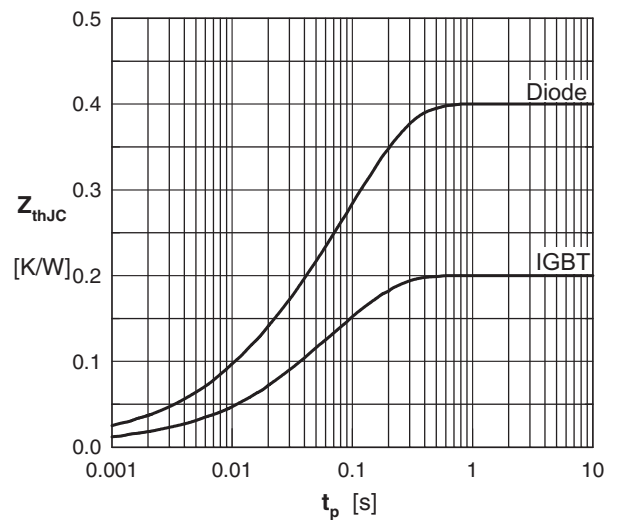


Fig. 12 Typ. transient thermal impedance

| IGBT  |          | FRD   |          |
|-------|----------|-------|----------|
| $R_i$ | $\tau_i$ | $R_i$ | $\tau_i$ |
| 0.003 | 0.00001  | 0.015 | 0.0005   |
| 0.010 | 0.0014   | 0.04  | 0.006    |
| 0.057 | 0.021    | 0.09  | 0.025    |
| 0.130 | 0.1      | 0.255 | 0.125    |

Fig. 13 Thermal coefficients

## Diode D1 - D6

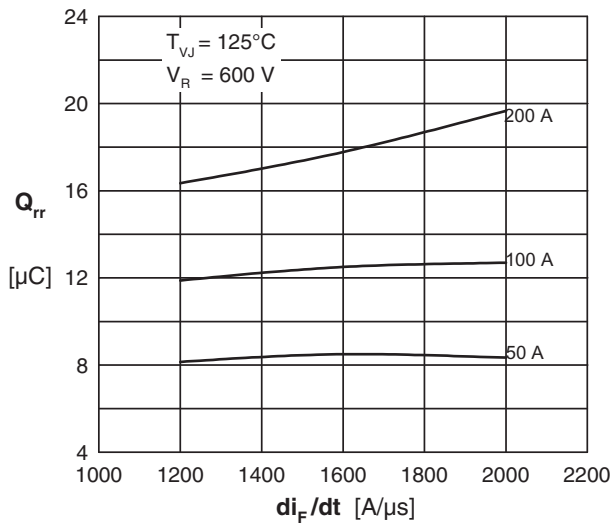


Fig. 14 Typ. reverse recov.charge  $Q_{rr}$  vs.  $di/dt$

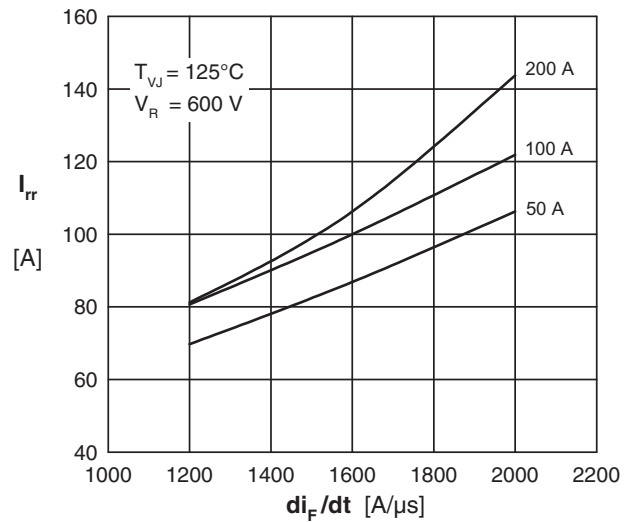


Fig. 15 Typ. peak reverse current  $I_{RM}$  vs.  $di/dt$

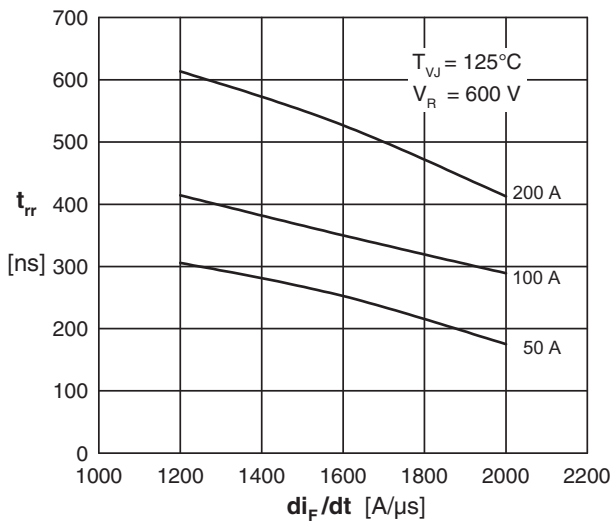


Fig. 16 Typ. recovery time  $t_{rr}$  versus  $di/dt$

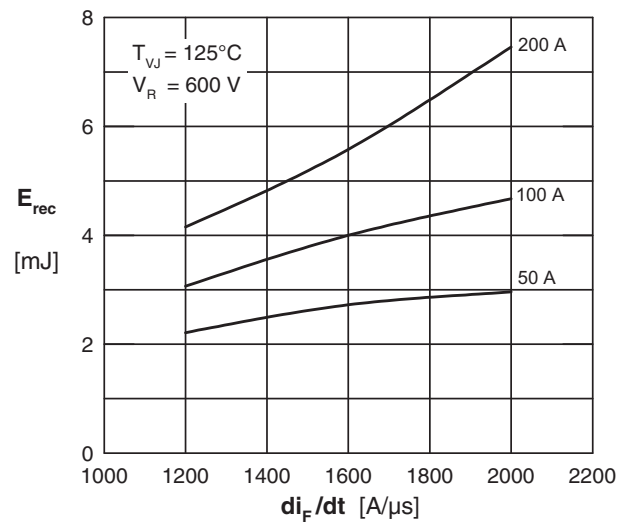


Fig. 17 Typ. recovery energy  $E_{rec}$  versus  $di/dt$